

#### N-Channel Enhancement Mode Field Effect Transistor

## **General Description**

The 150N85 is a N-channel Power MOSFET. It has specifically been designed to minimize input capacitance and gate charge. The device is therefore suitable in advanced high-efficiency switching applications.

### **Features**

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

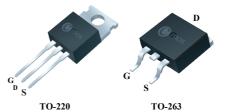
#### **Product Summary**

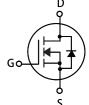
BVDSS	RDSON	ID
85V	$6.7 m\Omega$	150A

### **Applications**

- LED power controller
- DC-DC & DC-AC converters
- High current, High speed switching
- Solenoid and relay drivers
- Motor control, Audio amplifiers

## TO-220/263 Pin Configuration





Туре	Package	Marking
CMP150N85	TO-220	CMP150N85
CMB150N85	TO-263	CMB150N85

# **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
$V_{DS}$	Drain-Source Voltage	85	V	
V <sub>GS</sub>	Gate-Source Voltage	±20	V	
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current,VGS @ 10V	150	Α	
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current,VGS @ 10V	120	А	
I <sub>DM</sub>	Pulsed Drain Current	600	А	
EAS	Single Pulse Avalanche Energy <sup>1</sup>	800	mJ	
P <sub>D</sub> @T <sub>C</sub> =25°C	Power Dissipation	300	W	
T <sub>STG</sub>	Storage Temperature Range	-55 to 175	°C	
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 175	°C	

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit	
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)		65	°C/W	
$R_{ heta JC}$	Junction-to-Case		0.5	°C/W	

# CMP150N85/CMB150N85



#### **N-Channel Enhancement Mode Field Effect Transistor**

## Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	85			V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =20A			6.7	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250uA$	2		4	V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =85V, V <sub>GS</sub> =0V			1	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = ±20V , V <sub>DS</sub> =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =20A		23		S
$R_g$	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.0		Ω
Qg	Total Gate Charge	I <sub>D</sub> =20A		106		
$Q_{gs}$	Gate-Source Charge	V <sub>DD</sub> =50V		28		nC
$Q_{gd}$	Gate-Drain Charge	V <sub>GS</sub> = 10 V		41		
$T_{d(on)}$	Turn-On Delay Time	V <sub>DD</sub> =50V		27		
Tr	Rise Time	R <sub>L</sub> =2.5Ω		21		ne
$T_{d(off)}$	Turn-Off Delay Time	R <sub>G</sub> =3Ω		43		ns
T <sub>f</sub>	Fall Time	V <sub>GS</sub> =10V		14		
C <sub>iss</sub>	Input Capacitance			3500		
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =25V , V <sub>GS</sub> =0V , f=1MHz		1300		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			100		

## **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			150	Α
I <sub>SM</sub>	Pulsed Source Current				600	Α
V <sub>SD</sub>	Diode Forward Voltage	$V_{GS}$ =0V , $I_{S}$ =20A , $T_{J}$ =25 $^{\circ}$ C			1.2	V

#### Note:

1. The EAS data shows Max. rating . The test condition is  $V_{DS}$ =50V,  $V_{GS}$ =10V, L=1mH,  $I_{AS}$ =40A.

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